

Notice of References Cited

Application/Control No.

10/814,369

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

/Yonel Beaulieu/

Art Unit

3661

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,203,577	04-2007	Gunn et al.	701/3
*	B	US-7,256,710	08-2007	Mumaw et al.	340/973
*	C	US-7,321,318	01-2008	Crane et al.	340/971
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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